

Search Notes

Application/Control No.

10/790,380

Examiner

John A. Tweel, Jr.

Applicant(s)/Patent under
Reexamination

BLACK ET AL.

Art Unit

2636

SEARCHED

Class	Subclass	Date	Examiner
340	628	8/20/2005	JAT
	388.4	8/20/2005	JAT
	391.1	8/20/2005	JAT
	692	8/20/2005	JAT
	693.5	8/20/2005	JAT
	693.6	8/20/2005	JAT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner